

P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (m Ω)(TYP.)	I _D (A)	Q _g (TYP.)		
- 30	16 at V _{GS} = - 10 V	- 39 ^a			
	21 at V _{GS} = - 4.5 V	- 29 ^a	33 nC		

FEATURES

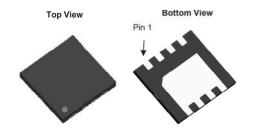
- DT-Trench Power MOSFET
- Thermally Enhanced DFN3X3 Package
 - Small Footprint Area
 - Low On-Resistance



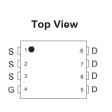
RoHS

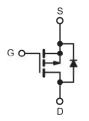
APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices



DFN 3x3-8L





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	• (1A - 25 C, unie			
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	- 30	V
Gate-Source Voltage		V_{GS}	± 20	
	T _C = 25 °C		- 39 ^a	
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	I _D	- 26 ^a	
Continuous Drain Current (1) = 130 C)	T _A = 25 °C	'D	- 19 ^{b, c}	
	T _A = 70 °C		- 10 ^{b, c}	A
Pulsed Drain Current (t = 300 µs)		I _{DM}	- 160	
Continuous Source-Drain Diode Current	T _C = 25 °C	Is	- 39 ^a	
Continuous Source-Dialit Diode Current	T _A = 25 °C	'8	- 15 ^{b, c}	
	T _C = 25 °C		45	
Maximum Power Dissipation	T _C = 70 °C	PD	38	\Box w
	T _A = 25 °C	, 0	3.9 ^{b, c}	
	T _A = 70 °C		2.2 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	25	35	°CAN	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3.3	4.5	°C/W	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 2 s.
- d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 10		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.2		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V, } V_{GS} = \pm 8 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V	_S = -30 V, V _{GS} = 0 V		- 1	
		V _{DS} = - 24 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V, } V_{GS} = -4.5 \text{ V}$	- 39			А
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 10 A		16	19.5	mΩ
	1 108(on)	V _{GS} = - 4.5 V, I _D = - 5 A		21	29	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		40		S
Dynamic ^b						
Input Capacitance	C _{iss}			1438		pF
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		160		
Reverse Transfer Capacitance	C _{rss}		-	152		
Total Gate Charge	Qq			33		nC
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 10 A		4		
Gate-Drain Charge	Q _{gd}			5.5		
Gate Resistance	R _g	f = 1 MHz		12		Ω
Turn-On Delay Time	t _{d(on)}			15		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 0.75 \Omega$		17		- ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -5 \text{ A}$, $V_{GEN} = -4.5 \text{ V}$, $R_g = 1 \Omega$		20		
Fall Time	t _f			40		
Turn-On Delay Time	t _{d(on)}			8		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_L = 0.75 \Omega$		11		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = -10 V, R_g = 1 Ω		15		
Fall Time	t _f			23		
Drain-Source Body Diode Characterist	ics					
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			- 39	A
Pulse Diode Forward Current	I _{SM}				160	
Body Diode Voltage	V _{SD}	I _S = - 10 A, V _{GS} = 0 V		- 0.7	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}		-	40	lu-	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 10 A, di/dt = 100 A/μs, T _J = 25 °C		20		nC
Reverse Recovery Fall Time	t _a	1 - 10 Λ, απαι - 100 Λ/μs, 11 - 25 C		15		nc
Reverse Recovery Rise Time	t _b			26		ns

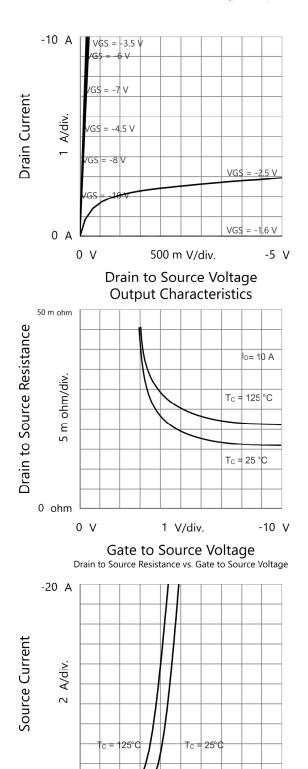
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

<sup>a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.</sup>



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



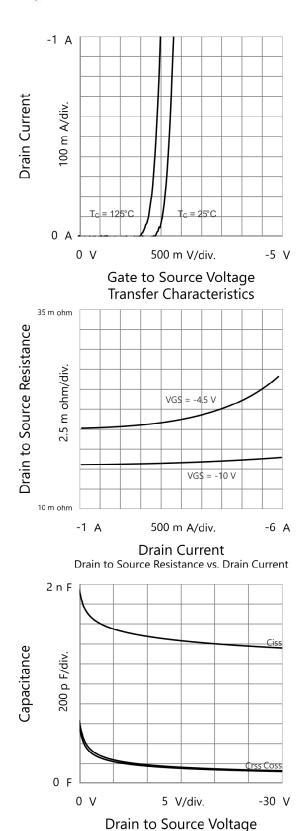
0 A

0 V

200 m V/div.

Source to Drain Voltage Body Diode Forward Characteristics

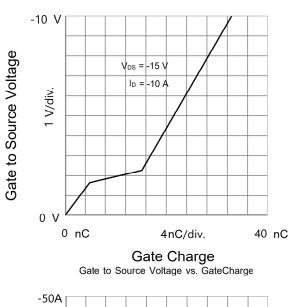
-2 V

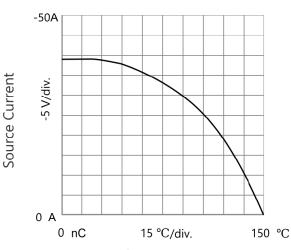


Capacitances

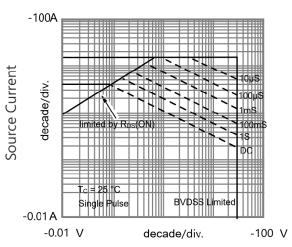


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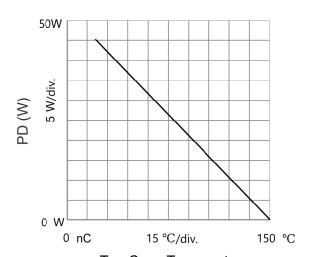






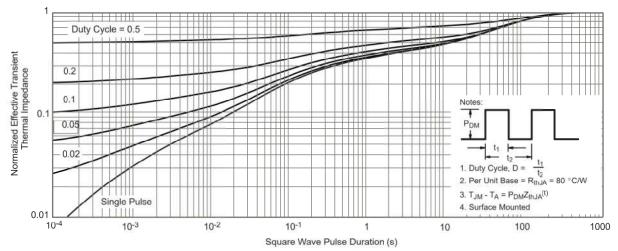


Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



T_C - Case Temperature

Power Derating



Normalized Thermal Transient Impedance, Junction-to-Ambient





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